N-channel dual gate MOSFET

Rev. 2 — 20 June 2011

Product data sheet

1. Product profile

1.1 General description

Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1217WR is encapsulated in the SOT343R plastic package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features and benefits

- Excellent low frequency noise performance
- Superior cross modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio

1.3 Applications

- Gain controlled low noise amplifiers for VHF and UHF applications with 5 V supply voltage
 - digital and analog television tuners
 - professional communication equipment



1.4 Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
					чур	-	
V _{DS}	drain-source voltage	DC		-	-	6	V
I _D	drain current	DC		-	-	30	mA
P _{tot}	total power dissipation	$T_{sp} \le 107 \ ^{\circ}C$	[1]	-	-	180	mW
y _{fs}	forward transfer admittance	$ f = 100 \text{ MHz}; \text{T}_{\text{j}} = 25 ^{\circ}\text{C}; $		23	27	38	mS
$C_{iss(G1)}$	input capacitance at gate1	f = 100 MHz	[2]	-	2.5	-	pF
C _{rss}	reverse transfer capacitance	f = 100 MHz	[2]	-	20	-	fF
NF	noise figure	$f = 400 \text{ MHz}; Y_S = Y_{S(opt)}$		-	1.0	-	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S(opt)}$		-	1.5	-	dB
Xmod	cross modulation	input level for k = 1 % at 40 dB AGC; f_w = 50 MHz; f_{unw} = 60 MHz	<u>[3]</u>	105	107	-	dBμV
Ti	junction temperature			-	-	150	°C

 $\label{eq:tau} [1] \quad T_{sp} \mbox{ is the temperature at the soldering point of the source lead.}$

[2] Calculated from S-parameters.

[3] Measured in Figure 17 test circuit.

Pinning information 2.

Pin	Description	Simplified outline	Graphic symbol
1	source		
2	drain		
3	gate 2		
4	gate 1		001aam153

3. Ordering information

Table 3. Ordering information						
Type number	Packag	je				
	Name	Description	Version			
BF1217WR	-	plastic surface-mounted package; reverse pinning; 4 leads	SOT343R			

BF1217WR Product data sheet

4. Marking

Table 4. Marking		
Type number	Marking	Description
BF1217WR	VA%	% = p : made in Hong Kong
		% = t : made in Malaysia
		% = w : made in China

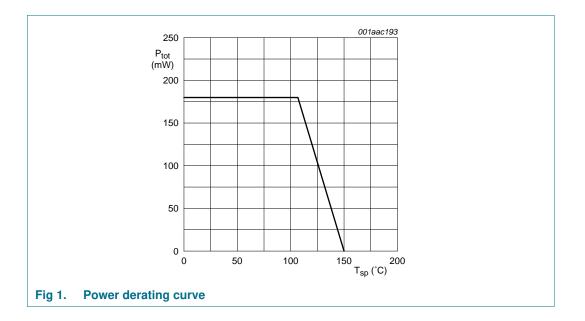
5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per MOSFE	т				
V _{DS}	drain-source voltage	DC	-	6	V
I _D	drain current	DC	-	30	mA
I _{G1}	gate1 current		-	±10	mA
I _{G2}	gate2 current		-	±10	mA
P _{tot}	total power dissipation	$T_{sp} \leq 107 ~^{\circ}C$	[1] -	180	mW
T _{stg}	storage temperature		-65	+150	°C
T _j	junction temperature		-	150	°C

[1] T_{sp} is the temperature at the soldering point of the source lead.



6. Thermal characteristics

Table 6.	Thermal characteristics						
Symbol	Parameter	Conditions	Тур	Unit			
R _{th(j-sp)}	thermal resistance from junction to solder point		240	K/W			

7. Static characteristics

Table 7. Static characteristics

 $T_{j} = 25 \ ^{\circ}C.$

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per MOSF	ET; unless otherwise specified					
V _{(BR)DSS}	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0 V; I_D = 10 \ \mu A$	6	-	-	V
V _{(BR)G1-SS}	gate1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0 V; I_{G1-S} = 10 mA$	6	-	10	V
V _{(BR)G2-SS}	gate2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0 V; I_{G2-S} = 10 mA$	6	-	10	V
$V_{F(S-G1)}$	forward source-gate1 voltage	$V_{G2-S} = V_{DS} = 0 V; I_{S-G1} = 10 mA$	0.5	-	1.5	V
V _{F(S-G2)}	forward source-gate2 voltage	$V_{G1-S} = V_{DS} = 0 V; I_{S-G2} = 10 mA$	0.5	-	1.5	V
V _{G1-S(th)}	gate1-source threshold voltage	V_{DS} = 5 V; $V_{G2\text{-}S}$ = 4 V; I_D = 100 μA	0.3	-	1.0	V
$V_{G2-S(th)}$	gate2-source threshold voltage	V_{DS} = 5 V; $V_{G1\text{-}S}$ = 5 V; I_{D} = 100 μA	0.4	-	1.0	V
I _{DS}	drain-source current	$V_{G2-S} = 4 V; V_{DS} = 5 V; R_{G1} = 82 k\Omega$	<u>[1]</u> -	-	24	mA
I _{G1-S}	gate1 cut-off current	$V_{G2-S} = 0 V; V_{DS} = 0 V; V_{G1-S} = 5 V$	-	-	50	nA
I _{G2-S}	gate2 cut-off current	$V_{G2-S} = 4 V; V_{DS} = 0 V; V_{G1-S} = 0 V$	-	-	20	nA

[1] R_{G1} connects gate1 to V_{GG} = 5 V. See Figure 17.

8. Dynamic characteristics

Table 8. Dynamic characteristics

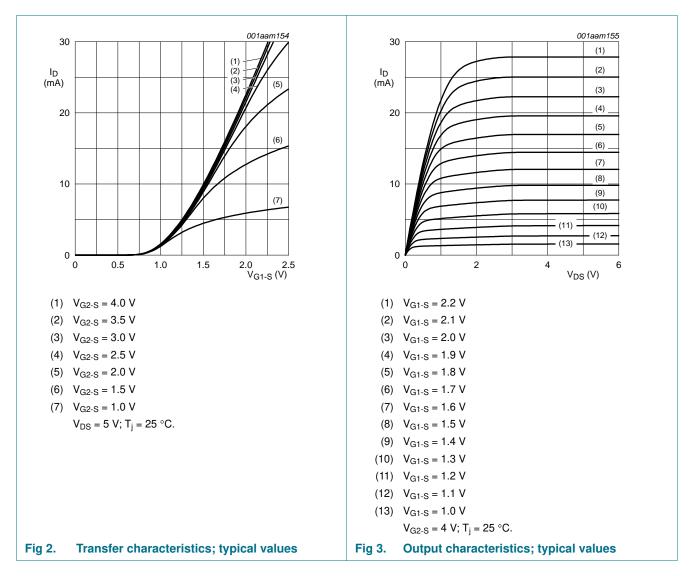
Common source; $T_{amb} = 25 \ ^{\circ}C$; $V_{G2-S} = 4 \ V$; $V_{DS} = 5 \ V$; $I_D = 18 \ mA$.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
y _{fs}	forward transfer admittance	f = 100 MHz; T _j = 25 °C		23	27	38	mS
$C_{iss(G1)}$	input capacitance at gate1	f = 100 MHz	[1]	-	2.5	-	pF
C _{iss(G2)}	input capacitance at gate2	f = 100 MHz	[1]	-	1.0	-	pF
C _{oss}	output capacitance	f = 100 MHz	[1]	-	0.8	-	pF
C _{rss}	reverse transfer capacitance	f = 100 MHz	[1]	-	20	-	fF
G _{tr}	transducer power gain	$B_S = B_{S(opt)}; B_L = B_{L(opt)}$	[1]				
		f = 200 MHz; G_S = 2 mS; G_L = 0.5 mS		-	34	-	dB
		$f = 400 \text{ MHz}; \text{ G}_{\text{S}} = 2 \text{ mS}; \text{ G}_{\text{L}} = 1 \text{ mS}$		-	30	-	dB
		f = 800 MHz; G_S = 3.3 mS; G_L = 1 mS		-	26	-	dB
NF	noise figure	$f = 400 \text{ MHz}; Y_S = Y_{S(opt)}$		-	1.0	-	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S(opt)}$		-	1.5	-	dB
Xmod	cross modulation	input level for k = 1 %; f_w = 50 MHz; f_{unw} = 60 MHz	[2]				
		at 0 dB AGC		90	104	-	dBμV
		at 10 dB AGC		-	100	-	dBμV
		at 20 dB AGC		-	104	-	dBμV
		at 40 dB AGC		105	107	-	dBμV

[1] Calculated from S-parameters.

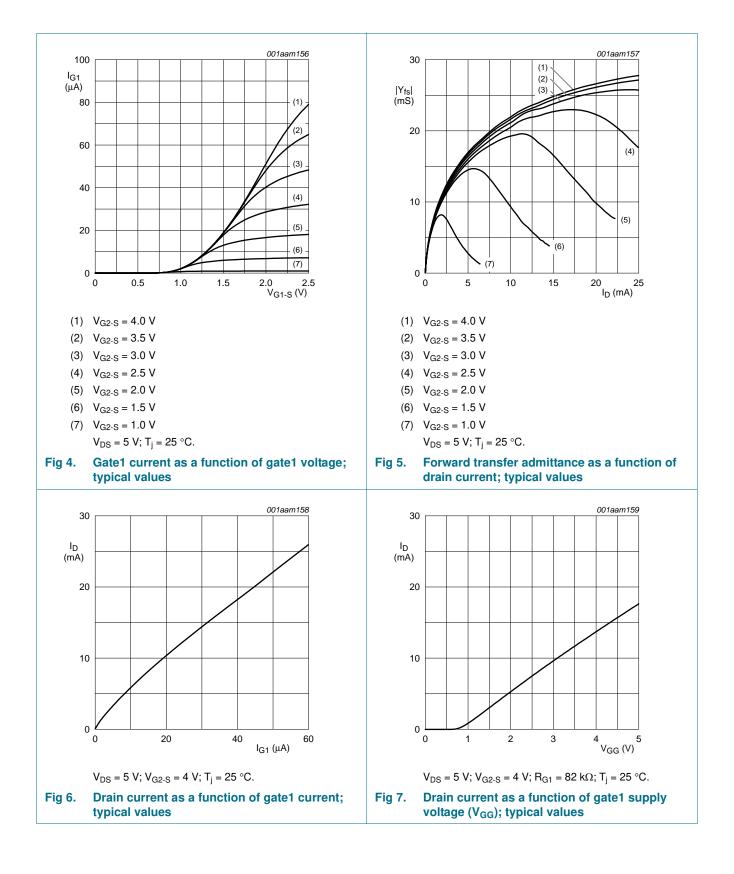
[2] Measured in Figure 17 test circuit.

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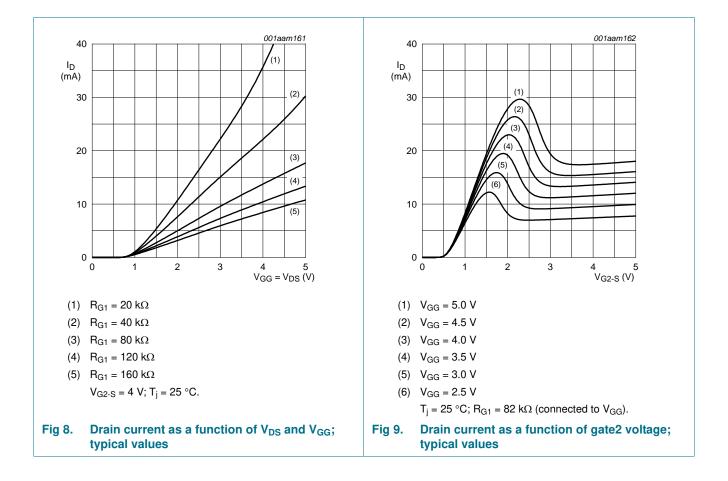


8.1 Graphs

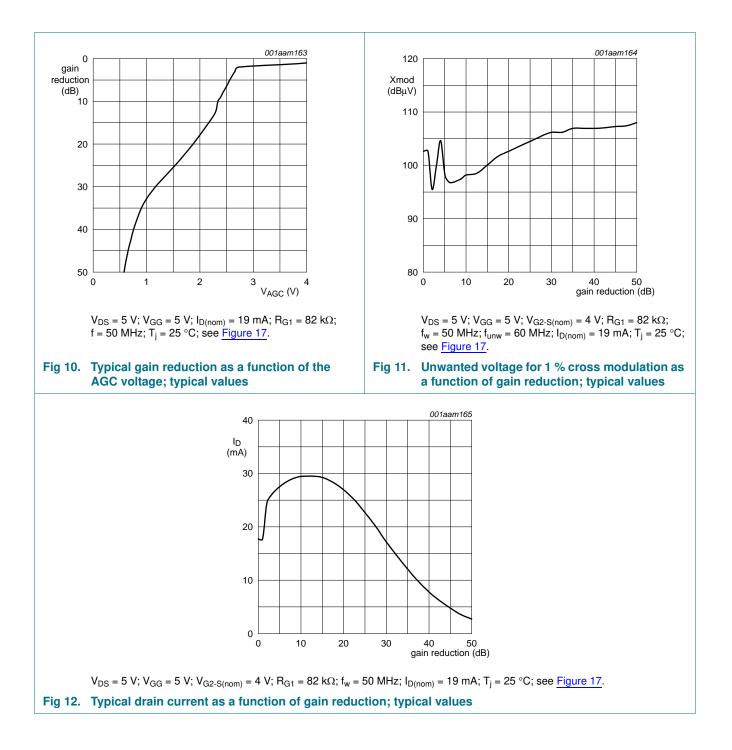
BF1217WR



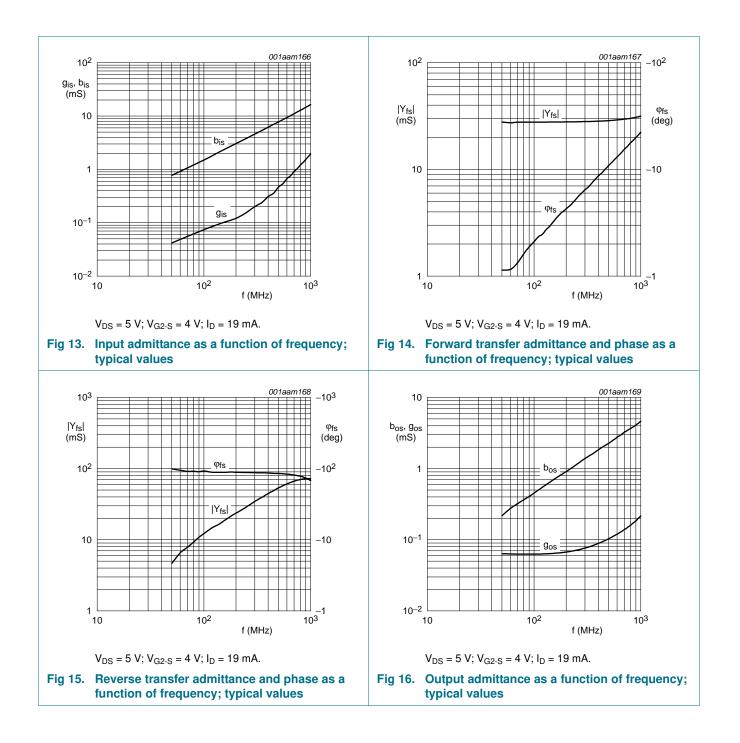
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BF1217WR



BF1217WR



8.2 Scattering parameters

Table 9. Scattering parameters

 $V_{DS} = 5 V$; $V_{G2-S} = 4 V$; $I_D = 19 mA$; $T_{amb} = 25 \ ^{\circ}C$; $Z_0 = 50 \Omega$; typical values.

f (MHz)	s ₁₁		s ₂₁		s ₁₂		s ₂₂	
	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)
40	0.9960	-3.50	2.77	177.20	0.00034	82.80	0.9945	-1.00
50	0.9957	-4.46	2.76	176.02	0.00046	82.50	0.9944	-1.28
100	0.9935	-8.66	2.74	172.19	0.00121	81.86	0.9938	-2.69
200	0.9880	-17.55	2.73	164.42	0.00231	80.28	0.9927	-5.39
300	0.9805	-26.17	2.69	156.64	0.00331	75.66	0.9909	-8.17
400	0.9712	-34.58	2.64	149.07	0.00414	71.21	0.9896	-10.79
500	0.9589	-42.78	2.58	141.74	0.00482	67.42	0.9872	-13.30
600	0.9451	-50.61	2.52	134.58	0.00526	64.33	0.9850	-16.08
700	0.9309	-58.23	2.45	127.49	0.00549	61.90	0.9836	-18.74
800	0.9166	-65.68	2.37	120.79	0.00551	60.77	0.9818	-21.05
900	0.9034	-72.70	2.29	114.37	0.00536	60.73	0.9796	-23.59
1000	0.8894	-79.30	2.22	107.90	0.00505	62.45	0.9781	-26.44

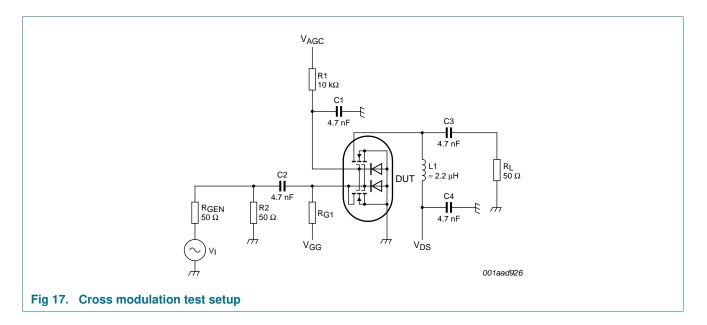
8.3 Noise data

Table 10. Noise data

 V_{DS} = 5 V; V_{G2-S} = 4 V; I_D = 19 mA, T_{amb} = 25 °C; typical values.

f (MHz)	NF _{min} (dB)	Γ _{opt}		r _n (ratio)
		(ratio)	(deg)	
400	1.0	0.798	29.5	0.907
800	1.5	0.703	57.7	0.749

9. Test information



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10. Package outline

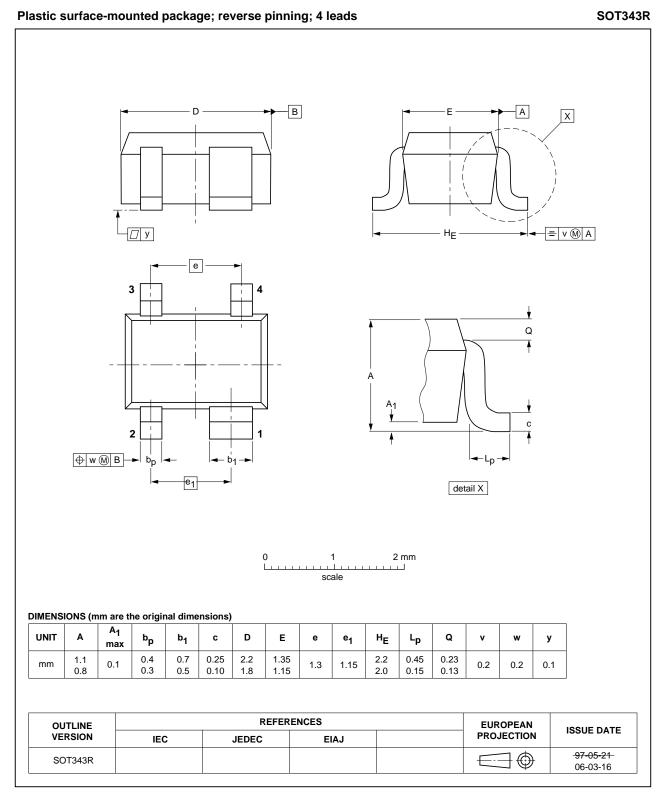


Fig 18. Package outline SOT343

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BF1217WR

11. Abbreviations

Table 11. A	bbreviations
Acronym	Description
AGC	Automatic Gain Control
DC	Direct Current
MOSFET	Metal-Oxide-Semiconductor Field-Effect Transistor
UHF	Ultra High Frequency
VHF	Very High Frequency

12. Revision history

Table 12.Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BF1217WR v.2	20110620	Product data sheet	-	BF1217WR v.1
Modifications:	 Package ou 	tline corrected.		
BF1217WR v.1	20100803	Product data sheet	-	-

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Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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